

Notice of References Cited

Application/Control No.

09/991,212

Applicant(s)/Patent Under
Reexamination
LAL ET AL.

Examiner

David J. Steadman

Art Unit

1652

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,693,473	12-1997	Shattuck-Eidens et al.	435/6
	B	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	TENEHOUSE et al. (1998) Am J Physiol 275:F527-F534
	V	BRENNER et al. (1999) Trends Genetics 15:132-133
	W	SCOTT et al. (1999) Nat Genet 21:440-443
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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